



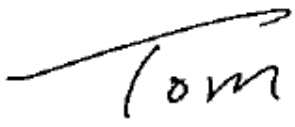
Test Report No.: FS160928N018

RF EXPOSURE REPORT

Applicant	Fengfan (Suzhou) Audio Technology Co., Ltd.
Address	E1-101, No.88 Dongchang Rd (i-Park), SIP Suzhou , Jiangsu Province, China(PRC)

Manufacturer or Supplier	Fengfan (Suzhou) Audio Technology Co., Ltd.
Address	E1-101, No.88 Dongchang Rd (i-Park), SIP Suzhou , Jiangsu Province, China(PRC)
Product	FIIL Carat Pro
Brand Name	FIIL
Model	Carat Pro
Additional Model & Model Difference	N/A
Date of tests	Oct. 15, 2016 ~ Nov. 02, 2016
☒ FCC Part 2 (Section 2.1091)	
☒ KDB 447498 D01	
☒ IEEE C95.1	

CONCLUSION: The submitted sample was found to COMPLY with the test requirement

Tested by Tom Chen Project Engineer / EMC Department	Approved by Glyn He Supervisor / EMC Department
	 Date: Nov. 09, 2016

This report is for your exclusive use. Any copying or replication of this report to or for any other person or entity, or use of our name or trademark, is permitted only with our prior written permission. This report sets forth our findings solely with respect to the test samples identified herein. The results set forth in this report are not indicative or representative of the quality or characteristics of the lot from which a test sample was taken or any similar or identical product unless specifically and expressly noted. Our report includes all of the tests requested by you and the results thereof based upon the information that you provided to us. You have 60 days from date of issuance of this report to notify us of any material error or omission caused by our negligence, provided, however, that such notice shall be in writing and shall specifically address the issue you wish to raise. A failure to raise such issue within the prescribed time shall constitute your unqualified acceptance of the completeness of this report, the tests conducted and the correctness of the report contents. Unless specific mention, the uncertainty of measurement has been explicitly taken into account to declare the compliance or non-compliance to the specification



Table of Contents

RELEASE CONTROL RECORD	3
1. CERTIFICATION.....	4
2. RF EXPOSURE DEFINE	5
3. CLASSIFICATION	5
4. SAR TEST EXCLUSION THRESHOLDS	6



Test Report No.: FS160928N018

RELEASE CONTROL RECORD

ISSUE NO.	REASON FOR CHANGE	DATE ISSUED
FS160928N018	Original release	Nov. 09, 2016

Bureau Veritas Shenzhen Co., Ltd.
Dongguan Branch

No. 34, Chenwulu Section, Guantai Rd., Houjie
Town, Dongguan City,
Guangdong 523942, China

Tel: +86 769 8593 5656
Fax: +86 769 8593 1080
Email: customerservice.dg@cn.bureauveritas.com



1. CERTIFICATION

FCC ID:	2AHGU-F007
PRODUCT:	FIIL Carat Pro
BRAND NAME:	FIIL
MODEL NO.:	Carat Pro
ADDITIONAL NO.:	N/A
TEST SAMPLE:	Engineering Sample
APPLICANT:	Fengfan (Suzhou) Audio Technology Co., Ltd.
STANDARDS:	FCC Part 2 (Section 2.1091)
	KDB 447498 D01
	IEEE C95.1

2. RF EXPOSURE DEFINE

The corresponding SAR Exclusion Threshold condition, listed below:

- 1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

$[(\text{max. power of channel, including tune-up tolerance, mW})/(\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}] \leq 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR, 16 where

- $f(\text{GHz})$ is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

- 2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following:
- a) [Threshold at 50 mm in step 1) + (test separation distance - 50 mm) $\cdot$ (f(MHz)/150)] mW, at 100MHz to 1500 MHz
 - b) [Threshold at 50 mm in step 1) + (test separation distance - 50 mm) $\cdot$ 10] mW at > 1500 MHz and ≤ 6 GHz
- 3) At frequencies below 100 MHz, the following may be considered for SAR test exclusion.
- a) The threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by $[1 + \log(100/f(\text{MHz}))]$ for test separation distances > 50 mm and < 200 mm.
 - b) The threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$ for test separation distances ≤ 50 mm.
 - c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable.

3. CLASSIFICATION

The antenna of this product, under normal use condition, is at less than 20cm away from the body of the user. So, this device is classified as **Portable Device**.



4. SAR TEST EXCLUSION THRESHOLDS

According to the KDB 447498:

The maximum average output power specified is 6.07dBm = 4.046mW

The SAR Exclusion Threshold Level:

= $3.0 * (\text{min. test separation distance, mm}) / \sqrt{\text{freq. in GHz}}$

= $3.0 * 5 / \sqrt{(2.480)}$ mW

= 9.53 mW

Since the source-based time-averaging conducted output power is well below the SAR low threshold level, so the EUT is considered to **comply** with SAR requirement without testing.